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ROOM TEMPERATURE HYDROGENATION IN FUNCTIONAL OXIDE NANOWIRES BY AN ELECTRIC FIELD VIA AIR NANOGAP

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Large reversible changes of the electronic transport properties of solid-state oxide materials induced by electrochemical fields have received much attention as a new research avenue in iontronics. The action on time-dependence of conductive modulation is slower. Despite the slow modulation, the emergence of non-linear, plastic and/or memristive behaviors provides an opportunity to obtain new abilities in information processing, like signal flow in brain, in addition to sensing and energy devices. In this conference, dramatic transport changes in VO₂ nanowires were demonstrated by electric field-induced hydrogenation at room temperature. As a suitable device structure to perform transport modulation through electrochemical reactions, we proposed a planar-type field effect transistor with side gates and a nanowire channel separated by air nanogaps (denoted PG-FET), as illustrated in Figure 1. This unique structure allowed us to investigate hydrogen intercalation and diffusion behavior in VO₂ channels with respect to both time and space. Figure 2 shows the reversible, non-volatile resistance changes in a VO₂ nanowire channel with a width (w) of 500 nm obtained by applying positive and negative VG at 300 K under a humidity of around 50%. The normalized resistance (R/R_0 , where R and R₀ are the measured resistance and resistance of the pristine device before applying a VG at 300 K, respectively) slowly decreased down to the saturation line at roughly $R/R_0 = 0.75$ during the application of VG = +100 V. This state was held after the removal of the VG. Namely, the device exhibited a non-volatile memory effect. The R/R_0 increased again with applying $V_G = -100$ V. Our results will contribute to further strategic researches to examine fundamental chemical and physical properties of devices and develop iontronic applications, as well as offering new directions to explore emerging functions for sensing, energy, and neuromorphologic devices combining ionic and electronic behaviors in solid-state materials.



Figure 1: Typical device structure (left) and an atomic force microscopy image of the VO₂ channel area (right). L, D and G indicate the source, drain and gate electrodes, respectively.



Figure 2: The dependence of normalized resistance (R/R_0) with V_G of 100 V and -100 V at 300 K.

Recent Publications

1. Manca N, Pellegrino L, Kanki T, Venstra W J, Mattoni G, Higuchi Y, Tanaka H, Caviglia A D and Marré D (2017) Selective high-frequency mechanical actuation driven by the VO₂ electronic instability. *Advanced Materials* 29, 1701618.
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Emerging Trends in Materials Science and Nanotechnology

Biography

Teruo Kanki has completed his PhD in Material Physics from Osaka University in 2004. After working as Visiting Researcher in IBM's Almaden Research Center from 2004 to 2006, he became a specially appointed Assistant Professor in Osa-

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